

12500 TI Boulevard, MS 8640, Dallas, Texas 75243

PCN#20160720001 Qualify ASESH as an additional Assembly & Test site for select devices Change Notification / Sample Request

Date: 7/22/2016

To: PREMIER FARNELL PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (PCN_ww_admin_team@list.ti.com).

Sincerely,

PCN Team SC Business Services

20160720001 Change Notification / Sample Request Attachments

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
MAX3221CPW	null
MAX3221CPWE4	null
MAX3221IPW	null
MAX3221IPWG4	null
MAX3221IPWR	null
TRS3221ECPWR	null
TRS3221EIPW	null
MAX3221CPWR	null
MAX3221ECPWR	null
MAX3221EIPW	null
MAX3221EIPWR	null
TRS3221EIPWR	null
MAX3221ECPW	null

Technical details of this Product Change follow on the next page(s).

	it itali	nber:	20	20160720001 PCN Date: 07/				07/22/20	16				
Titl	le:	Qualify ASE	SH a	SH as an additional Assembly & Test site for select devices									
Cus	stome	r Contact:	PC	N Man	ager De	pt:	Quality Se	rvice	es				
Pro	pose	d 1 st Ship D	ate:	10	0/22/2016	Esti	mated Samp	ole <i>A</i>	Availa	bility:	Prov Requ	rided upon uest	
	ange '												
		mbly Site			Assembly Proc					mbly Ma			
	Desig				Electrical Spec					nanical S	_	ication	
	Test				Packing/Shipp					Process			
\mathbf{H}		r Bump Site r Fab Site		H	Wafer Bump M Wafer Fab Mat			Н		er Bump er Fab Pi			
	ware	i rab Site		Ħ	Part number c				ware	парг	000	3	
			1				etails	I					
Des	script	ion of Chan	ae:				Ctans						
				sed to	o announce the	e qu	alification of	ASE	SH as	an addi	tional	Assembly	&
Tes	t site 1	for the list of	f dev	ices s	shown below.	Mat	terial differen	ces l	betwee	en sites	as fo	llows.	
	Asse	mbly Site	Ass	semb	ly Site Origin	A	Assembly Co	untı	ry Cod	le As	ssem	bly City	
	TI N	Malaysia			MLA		MY			K	uala	Lumpur	
	A	SESH			ASH		CN				Shai	nghai	
Ma	terial	Differences	s:										
					Malaysia		ASESH						
		Compound			4042500	-	EY1000063						
		compound			4206193		EN2000507						
	Lea	nd finish			NiPdAu		Matte Sn						
Upon expiration of this PCN, TI will combine lead free solutions in a single <u>standard part number</u> , for example; <u>MAX3221CPWR</u> – can ship with both Matte Sn and NiPdAu. When available customers may specify NiPdAu finish by ordering the part with the G4 suffix, e.g. <u>MAX3221CPWRG4.</u> " Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ.						1							
Rea	ason f	or Change:											
		y of Supply											
Ant	ticipat	ted impact	on F	it, Fo	orm, Function	ı, Q	uality or Re	liabi	ility (Į	positive	e / ne	egative):	
Nor													
Ant	ticipat	ted impact	on M	1ater	ial Declaration	on							
		npact to the rial Declarat		\boxtimes	Material Declar production da release. Upor obtained from	ita a n pr	and will be averoduction rele	ailat ase	ole foll the re	owing th	ne pro	oduction	า

Changes to product identification resulting from this PCN:

Assembly Site		
TI Malaysia	Assembly Site Origin (22L)	ASO: MLA
ASESH	Assembly Site Origin (22L)	ASO: ASH

Sample product shipping label (not actual product label)





(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483\$12 (P) (P) (V) 0033317

(2P) REV: (V) 0033317 (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS

Topside Device marking:

TTEM: 5A (L)TO:3750

Assembly site code for MLA = K

Assembly site code for ASH = A

Product Affected

MAX3221CPW	MAX3221ECPWG4	MAX3221IPW	TRS3221ECPWR-LI	
MAX3221CPWE4	MAX3221ECPWR	MAX3221IPWG4	TRS3221EIPW	
MAX3221CPWG4	MAX3221EIPW	MAX3221IPWR	TRS3221EIPWR	
MAX3221CPWR	MAX3221EIPWE4	MAX3221IPWRG4	TRS3221EIPWRG4	
MAX3221CPWRE4	MAX3221EIPWG4	TRS3221CPWR	TRS3221IPW	
MAX3221CPWRG4	MAX3221EIPWR	TRS3221CPWRG4	TRS3221IPWR	
MAX3221ECPW	MAX3221EIPWRE4	TRS3221ECPW		
MAX3221ECPWE4	MAX3221EIPWRG4	TRS3221ECPWR		

Qualification Report Multisource MAX3221ECPWR and MAX3221CPWR to ASESH Approve Date 01-Jul-2016

Product Attributes

Attributes	Qual Device: MAX3221CPWR	Qual Device: MAX3221ECPWR	QBS Product Reference: TRS3243CDB	QBS Process Reference: MAX232ECDW	QBS Process Reference: MAX3237EDW
Assembly Site	ASESH	ASESH	MLA	MLA	MLA
Package Family	TSSOP	TSSOP	SSOP	SOIC	SOIC
Flammability Rating	UL 94 V0	UL 94 V0	UL 94 V0	UL 94 V-0	UL 94 V-0
Wafer Fab Supplier	DFAB	DFAB	DFAB	DFAB	DFAB
Wafer Process	LBC3S	LBC3S	LBC3S	LBC3S	LBC3S

Attributes	QBS Process	QBS Package	QBS Package	QBS Package
Attributes	Reference:	Reference:	Reference:	Reference:

	SN75C3238EDW	SN74LV14APWR	SN74LVC14APWR	ULN2003APW
Assembly Site	TAI	ASESH	ASE-SH	ASESH
Package Family	SOIC	TSSOP	TSSOP	TSSOP
Flammability Rating	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0
Wafer Fab Supplier	DFAB	SFAB	FFAB	SFAB
Wafer Process	LBC3S	EPIC1-S	P9750	JI

⁻ QBS: Qual By Similarity

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: MAX3221CPWR	Qual Device: MAX3221ECP WR	QBS Product Reference: TRS3243CDB	QBS Process Reference: MAX232ECD W
AC	Autoclave 121C	96 Hours	-	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	-	-	Pass	Pass
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	-
ESD	ESD - IEC Air Gap	15000 V	-	-	-	1/3/0
HBM	ESD - HBM	4000 V	1/3/0	1/3/0	-	-
НВМ	ESD - HBM -HIGH	15000 V	-	-	1/3/0	1/3/0
CDM	ESD - CDM	1500 V	1/3/0	1/3/0	-	1/3/0
HTOL	Life Test, 150C	300 Hours	-	-	1/77/0	-
HTSL	High Temp. Storage Bake, 150C	1000 Hours	-	-	-	-
LU	Latch-up	(per JESD78)	1/6/0	1/6/0	1/6/0	3/9/0
TC	Temperature Cycle, -65C/150C	500 Cycles	-	-	-	-
THB	Biased Temperature and Humidity, 85C/85%RH	1000 Hours	-	-	-	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	-	-
WBP	Bond Strength	Wires	-	-	-	-

Туре	Test Name / Condition	Duration	QBS Process Reference: MAX3237E DW	QBS Process Reference: SN75C3238 EDW	QBS Package Reference: SN74LV14 APWR	QBS Package Reference: SN74LVC14A PWR	QBS Package Reference: ULN2003AP W
AC	Autoclave 121C	96 Hours	1/77/0	1/77/0	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	-	-	Pass	Pass	Pass
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	1/77/0	1/77/0	1/77/0
ESD	ESD - IEC Air Gap	15000 V	-	-	-	-	-
HBM	ESD - HBM	4000 V	-	-	-	-	-

⁻ Qual Devices qualified at LEVEL1-260CG: MAX3221CPWR, MAX3221ECPWR

⁻ Device MAX3221ECPWR contains multiple dies.

НВМ	ESD - HBM -HIGH	15000 V	-	-	-	-	-
CDM	ESD - CDM	1500 V	-	-	-	-	-
HTOL	Life Test, 150C	300 Hours	1/40/0	1/40/0	1/77/0	1/77/0	1/77/0
HTSL	High Temp. Storage Bake, 150C	1000 Hours	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0
LU	Latch-up	(per JESD78)	-	-	-	-	-
TC	Temperature Cycle, - 65C/150C	500 Cycles	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0
THB	Biased Temperature and Humidity, 85C/85%RH	1000 Hours	1/26/0	1/26/0	-	-	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	1/77/0	1/77/0	1/77/0
WBP	Bond Strength	Wires	-	-	1/76/0	1/76/0	1/76/0

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at Tl's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com